


<b>Search Notes</b>  	<b>Application/Control No.</b>  10540738	<b>Applicant(s)/Patent Under Reexamination</b>  EBIHARA, YOSHIYUKI
	<b>Examiner</b>  LINDSAY M LOW	<b>Art Unit</b>  3721

SEARCHED			
Class	Subclass	Date	Examiner
227	120, 119, 134, 109, 125	2/18/2008	LL
206	206, 207	2/18/2008	LL
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SEARCH NOTES		
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INTERFERENCE SEARCH			
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